













SM74611 SNVS903B - DECEMBER 2012 - REVISED MAY 2016

SM74611 Smart Bypass Diode

1 Features

- Maximum Reverse Voltage (V_R) of 30 V
- Operating Forward Current (I_F) of up to 15 A
- Low Average Forward Voltage (26 mV at 8 A)
- Less Power Dissipation than Schottky Diode
- Lower Leakage Current than Schottky Diode
- Footprint and Pin-Compatible With Conventional D2PAK Schottky Diode
- Operating Range (T_J) of -40°C to 125°C

2 Applications

- · Bypass Diodes for Photovoltaic Panels
- Bypass Diodes for Microinverter and Power Optimizer

3 Description

The SM74611 device is a smart bypass diode used in photovoltaic applications. The SM74611 device serves the purpose of providing an alternate path for string current when parts of the panel are shaded during normal operation. Without bypass diodes, the shaded cells will exhibit a hot spot which is caused by excessive power dissipation in the reverse biased cells.

Currently, conventional P-N junction diodes or Schottky diodes are used to mitigate this issue. Unfortunately the forward voltage drop for these diodes is still considered high (approximately 0.6 V for normal diodes and 0.4 V for Schottky). With 10 A of currents flowing through these diodes, the power dissipation can reach as high as 6 W. This in turn will raise the temperature inside the junction box where these diodes normally reside and reduce module reliability.

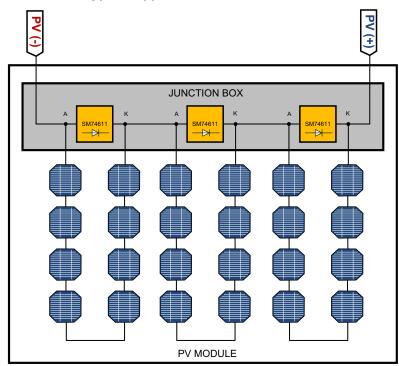
The advantage of the SM74611 is that it has a lower forward voltage drop than P-N junction and Schottky diodes. It has a typical average forward voltage drop of 26 mV at 8 A of current. This translates into typical power dissipation of 208 mW, which is significantly lower than the 3.2 W of conventional Schottky diodes. The SM74611 is also footprint and pin compatible with conventional D2PAK Schottky diodes, making it a drop-in replacement in many applications.

Device Information⁽¹⁾

PART NUMBER	PACKAGE	BODY SIZE (NOM)			
SM74611	TO-263 (3)	10.18 mm × 8.41 mm			

(1) For all available packages, see the orderable addendum at the end of the datasheet.

Typical Application in a Junction Box



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Table of Contents

Features 1	7.3 Feature Description	6
Applications 1	7.4 Device Functional Modes	7
	8 Application and Implementation	8
•	8.1 Application Information	8
-		
_		
•	• • •	
<u> </u>	•	
<u> </u>	10.2 Layout Example	1 1
	11 Device and Documentation Support	12
	11.2 Trademarks	12
· · · · · · · · · · · · · · · · · · ·	11.3 Electrostatic Discharge Caution	12
• • • • • • • • • • • • • • • • • • •	11.4 Glossary	12
7.2 Functional Block Diagram	12 Mechanical, Packaging, and Orderable Information	12
	Applications 1 Description 1 Revision History 2 Pin Configuration and Functions 3 Specifications 3 6.1 Absolute Maximum Ratings 3 6.2 ESD Ratings 4 6.3 Recommended Operating Conditions 4 6.4 Thermal Information 4 6.5 Electrical Characteristics 4 6.6 Typical Characteristics 5 Detailed Description 6 7.1 Overview 6	Applications17.4 Device Functional ModesDescription18 Application and ImplementationRevision History28.1 Application InformationPin Configuration and Functions38.2 Typical ApplicationSpecifications39 Power Supply Recommendations6.1 Absolute Maximum Ratings310 Layout6.2 ESD Ratings410.1 Layout Guidelines6.3 Recommended Operating Conditions410.2 Layout Example6.4 Thermal Information411 Device and Documentation Support6.5 Electrical Characteristics411.1 Community Resources6.6 Typical Characteristics511.2 TrademarksDetailed Description611.3 Electrostatic Discharge Caution7.1 Overview611.4 Glossary

4 Revision History

Changes from Revision A (November 2014) to Revision B

Page

 Added Device Functional Modes, Application and Implementation section, Power Supply Recommendations section, Layout section, Device and Documentation Support section, and Mechanical, Packaging, and Orderable Information section

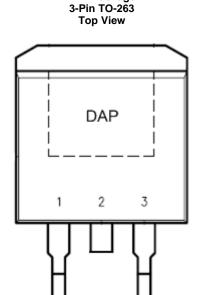
Changes from Original (December 2012) to Revision A

Page

Added new junction temperature for t ≤ 1 hour
 Added Thermal Table
 Changed typical characteristic curves



5 Pin Configuration and Functions



KTT Package

Pin Functions

PI	PIN		DESCRIPTION					
NAME	NO.	I/O	DESCRIPTION					
ANODE	1 ⁽¹⁾		Connect both of these pine to the projective side of the DV cells					
ANODE	3 ⁽¹⁾		Connect both of these pins to the negative side of the PV cells					
CATHODE	2 ⁽²⁾	0	Discount the DAD are about distance the Occasion the DAD to the activity of the DV cells					
CATHODE	DAP ⁽²⁾	0	Pin 2 and the DAP are shorted internally. Connect the DAP to the positive side of the PV cells					

- (1) Pin 1 and Pin 3 must be connected together for proper operation.
- (2) Package drawing at the end of datasheet is shown without Pin 2 being trimmed.

6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted) (1)(2)

	MIN	MAX	UNIT
DC reverse voltage		30	V
Forward current		24	Α
Junction temperature, t ≤ 1 hour		135	°C
Storage temperature, T _{stg}	-65	125	°C

- (1) Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) System must be thermally managed so as not to exceed maximum junction temperature



6.2 ESD Ratings

			VALUE	UNIT
V	V _(FOD) Electrostatic discharge	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 (1)	±1000	\/
V _(ESD) EI		ectrostatic discharge Charged-device model (CDM), per JEDEC specification JESD22-C101 (2)		V

JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process. Pins listed as ±1000 V may actually have higher performance.

6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted) (1)

	MIN	MAX	UNIT
DC reverse voltage		28	٧
Junction temperature (T _J)	-40	125	°C
Forward current	0	15	Α

⁽¹⁾ System must be thermally managed so as not to exceed maximum junction temperature

6.4 Thermal Information

		SM74611	
	THERMAL METRIC ⁽¹⁾	KTT (TO-263)	UNIT
		3 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	40.4	°C/W
R _{0JC(top)}	Junction-to-case (top) thermal resistance	42.6	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	23.0	°C/W
Ψлт	Junction-to-top characterization parameter	9.8	°C/W
ΨЈВ	Junction-to-board characterization parameter	22.0	°C/W
R _{0JC(bot)}	Junction-to-case (bottom) thermal resistance	0.5	°C/W

⁽¹⁾ For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report, SPRA953.

6.5 Electrical Characteristics

	PARAMETER	TEST	TEST CONDITIONS			UNIT	
I _{F(AVG)}	Forward current			8	15	Α	
V _{F(AVG)}	Forward voltage	I _F = 8 A	T _J = 25°C	26		mV	
			T _J = 25°C	208			
		I _F = 8 A	T _J = 125°C	450			
P_D	Power dissipation		-40°C to 125°C ⁽¹⁾		575	mW	
		45.0	T _J = 25°C	695			
		I _F = 15 A	T _J = 125°C	1389			
5	Dutu suels	1 O A	$T_J = 25^{\circ}C$	99.5%			
D	Duty cycle	I _F = 8 A	T _J = 125°C	96.0%			
	Deverse leekens sunset	V 20.V	T _J = 25°C	0.3			
I _R	Reverse leakage current	V _{REVERSE} = 28 V	T _J = 125°C	3.3		μA	

⁽¹⁾ Limits -40° C to 125° C apply over the entire junction temperature range for operation. Limits appearing in normal type apply for $T_A = T_J = 25^{\circ}$ C.

⁽²⁾ JEDÉC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process. Pins listed as ±250 V may actually have higher performance.



6.6 Typical Characteristics

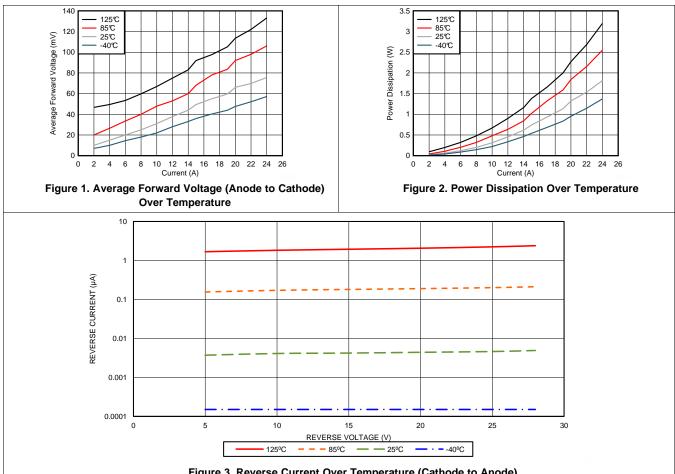


Figure 3. Reverse Current Over Temperature (Cathode to Anode)

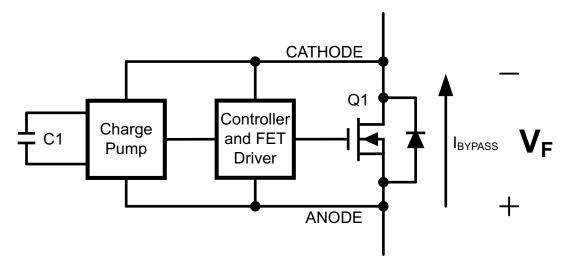


7 Detailed Description

7.1 Overview

The SM74611 is designed for use as a bypass diode in photovoltaic modules. The SM74611 uses a charge pump to drive an N-channel FET to provide a resistive path for the bypass current to flow.

7.2 Functional Block Diagram



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Figure 4. SM74611 Block Diagram

7.3 Feature Description

The operational description is described in the following sections. See Figure 4 and Figure 5.

7.3.1 From t_0 to t_1

When cells in the solar panels are shaded, the FET Q1 is off and the bypass current flows through the body diode of the FET as shown on Figure 4. This current produces a voltage drop (V_F) across ANODE and CATHODE terminal of the bypass diode. During this time, the charge pump circuitry is active and charging capacitor C1 to a higher voltage.

7.3.2 At t₁

Once the voltage on the capacitor reaches its predetermined voltage level, the charge pump is disabled and the capacitor voltage is used to drive the FET through the FET driver stage.

7.3.3 From t₁ to t₂

When the FET is active, it provides a low resistive path for the bypass current to flow thus minimizing the power dissipation across ANODE and CATHODE. Because the FET is active, the voltage across the ANODE and CATHODE is too low to operate the charge pump. During this time, the stored charge on C1 is used to supply the controller as well as drive the FET.

7.3.4 At t₂

When the voltage on the capacitor C1 reaches its predetermined lower level, the FET driver shuts off the FET. The bypass current will then begin to flow through the body diode of the FET, causing the FET body diode voltage drop of approximately 0.6 V to appear across ANODE and CATHODE. The charge pump circuitry is reactivated and begins charging the capacitor C1. This cycle repeats until the shade on the panel is removed and the string current begins to flow through the PV cells instead of the body diode of the FET.

Submit Documentation Feedback



Feature Description (continued)

The key factor to minimizing the power dissipation on the device is to keep the FET on at a high duty cycle. The average forward voltage drop will then be reduced to a much lower voltage than for a Schottky or regular P-N junction diode.

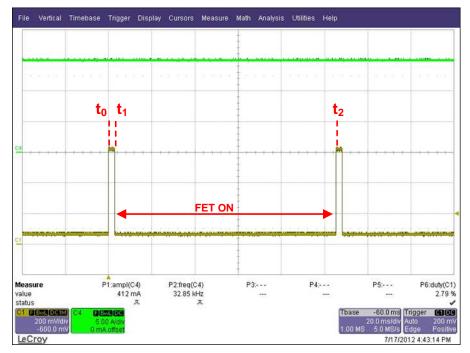


Figure 5. ANODE to CATHODE Voltage (Ch1) With I_{BYPASS} = 15 A (Ch4) for SM74611 in Junction Box at 85°C Ambient

7.4 Device Functional Modes

7.4.1 FET Q1 OFF

Initially, the internal FET Q1 is OFF. This is between t_0 and t_1 as shown in Figure 5. When current begins flowing from ANODE to CATHODE, the FET Q1 body diode conducts with a voltage drop V_F .

7.4.2 FET Q1 ON

The FET Q1 is ON between t_1 and t_2 as shown in Figure 5. During this time, the FET gate is driven and current flows through the FET through a low resistive path.



8 Application and Implementation

NOTE

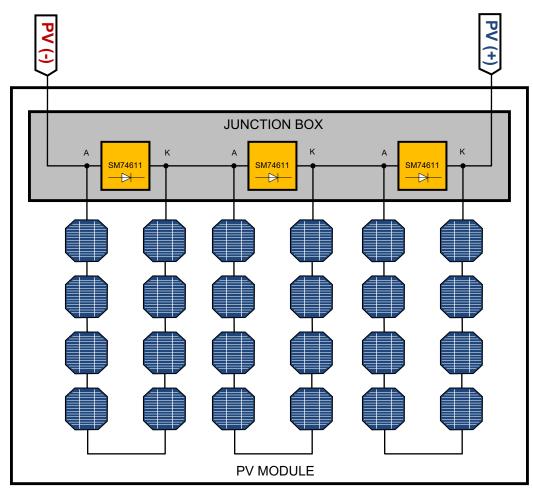
Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

8.1 Application Information

The SM74611 smart bypass diode is a drop-in replacement for traditional bypass diodes used in photovoltaic (PV) applications. When compared to a typical diode, which has a typical 0.7-V drop during forward conduction, the SM74611 dissipates significantly less power and allows PV applications such as solar junction boxes to run much cooler.

8.2 Typical Application

The application diagram shown in Figure 6 shows 3 SM74611 Smart Bypass Diodes connected in series, each providing a bypass path for 8 solar cells for a total of 24 solar cells.



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Figure 6. Solar Junction Box



Typical Application (continued)

8.2.1 Design Requirements

Table 1 lists the parameters for Figure 6

Table 1. Design Parameters

PARAMETER	EXAMPLE VALUE
Minimum input voltage VIN _{MIN}	1 V
Maximum input voltage VIN _{MAX}	28 V
Maximum forward current I _{MAX}	20 A
Junction temperature range T _J	−40°C to 125°C

8.2.2 Detailed Design Procedure

The SM74611 is primarily used in solar junction boxes to improve the efficiency compared to commonly used P-N junction or Schottky diodes. The junction boxes have 2 or 3 diodes in series connected across the solar panel, each diode connected across a substring of solar cells, as shown in Figure 6. Standard bodies like IEC and UL mandate certain thermal tests for bypass diodes in junction boxes. At the time of this writing, the applicable specifications include IEC61215, IEC61646, EN 50548, IEC62790, and UL3730. The test procedures across these specifications are similar and include the following:

- Apply temperature probe to the diode (in the case of SM74611 the smart bypass diode) body
- Apply 75 ± 50°C to the junction box, containing the 2 to 3 (smart bypass) diodes
- Apply panel-rated, short-circuit current through the box for 1 hour
- Increase the current to 1.25 times the rated value and continue testing for another 1 hour

While the specifications may not specify how the temperature must be maintained, it is expected that there will be no air flow as in a real application behind a solar panel. Also there may be no specification of how the temperature is raised from room to 750°C. TI recommends a gradual and controlled increase to avoid shock to the product under test. Using a good climate chamber or oven is needed to ensure uniformity and consistency of temperature during test and from test of one junction box to another. Similar precautions are also necessary with the thermocouples and temperature probes used during the tests. It is a good idea to check the equipment used with the certification body. The junction box should be operational after these tests. Due to body diode pulses, a simple diode tester cannot be used to test the Smart Bypass Diode. An example testing scheme is shown in *Application Curve*. To avoid component failure, the Smart Bypass Diode junction temperature must not exceed the maximum rating during these tests. See *Absolute Maximum Ratings* for the SM74611 limits. The junction temperature is calculated based on the measured values from the temperature probe.

The temperature probe could be applied on the top (plastic case) or bottom (tab) of the SM74611 body, as shown in Figure 7. Methods of applying this probe vary from Kapton tape, 2K-resins (for top) to soldering (bottom tab). It is good to check with the certification body regarding the acceptable method.

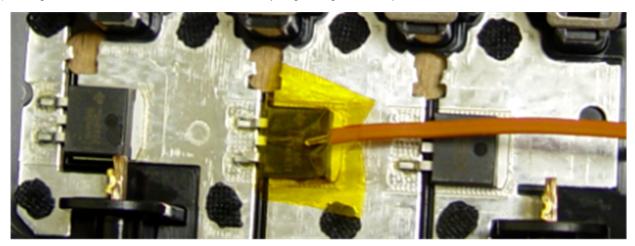


Figure 7. Temperature Probe Attachment During Thermal Test



Because the SM74611 Smart Bypass Diode cycles the FET ON and OFF to recharge the charge pump, occasionally the body diode conducts instead of the FET. Therefore the drop across the Smart Bypass Diode is not constant even at constant load. Due to this switching behavior, a normal diode tester can not be used to test the operation of the Smart Bypass Diode. The following test scheme is provided, as an example, with junction box application consideration. See Figure 8 while reading the following test steps:

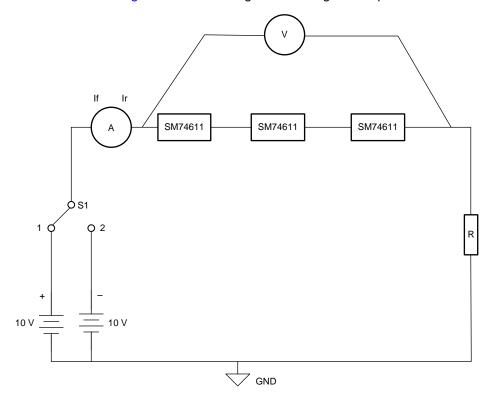


Figure 8. Example Test Setup for SM74611

Step 1: Testing Forward voltage drop (set R such that If => 1 A)

- Toggle S1 to position 1
- Make sure to see If reading of 10V/R
- Measure Voltage across 3 SM74611 or 1 ea SM74611
- If the setup is working properly, Vf will be less than 150 mV (Rdson losses)

Potential Fault Conditions

- SM74611 FET is not turning ON -> the measured voltage will be > 500 mV
- SM74611 device is not soldered and open -> No If current is seen

Step 2: Testing Reverse voltage turn OFF

- Toggle S1 to position 2
- Measure current Ir which is expected to be < 1 μA

Potential Fault Conditions

• SM74611 FET is shorted or board short is present, the measured current *Ir* is same as *If* but with reverse polarity. (This is only in the case of testing each SM74611 and not applicable for testing 3 together).



8.2.3 Application Curve

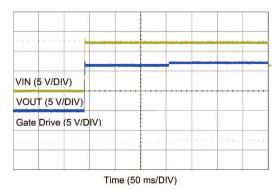


Figure 9. Start-Up Related to Input Voltage from the Panel

9 Power Supply Recommendations

The SM74611 is designed to be implemented as bypass diode in photovoltaic modules. System designer must ensure that the voltage level from solar modules does not exceed 28 V. At the time of this writing, the applicable specifications include IEC61215, IEC61646, EN 50548, IEC62790, and UL3730. This is because the SM74611 can protect against a maximum of –28 V as a bypass diode. The internal MOSFET of SM74611 can pass up to 15-A current. Drawing more current can damage the internal MOSFET permanently.

10 Layout

10.1 Layout Guidelines

Some layout guidelines must be followed to ensure proper conduction from ANODE to CATHODE pins. ANODE and CATHODE traces carrying the load current must be wide to reduce the amount of parasitic trace inductance as shown in Figure 10.

10.2 Layout Example

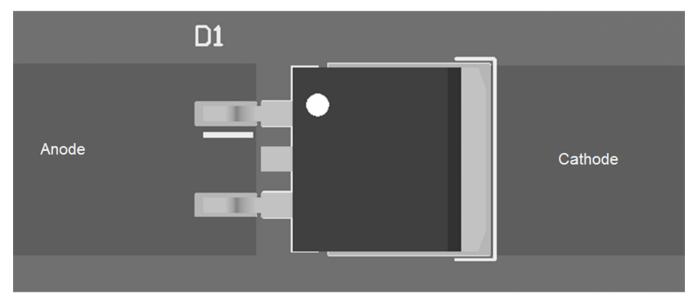


Figure 10. Layout Example for SM74611

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Product Folder Links: SM74611



11 Device and Documentation Support

11.1 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

TI E2E™ Online Community TI's Engineer-to-Engineer (E2E) Community. Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

Design Support *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

11.2 Trademarks

E2E is a trademark of Texas Instruments.

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11.3 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

11.4 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



PACKAGE OPTION ADDENDUM

10-Dec-2020

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
SM74611KTTR	ACTIVE	DDPAK/ TO-263	KTT	3	500	RoHS-Exempt & Green	SN	Level-3-245C-168 HR	-40 to 125	SM74611KTT	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing			Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SM74611KTTR	DDPAK/ TO-263	KTT	3	500	330.0	24.4	10.6	15.8	4.9	16.0	24.0	Q2

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*All dimensions are nominal

ĺ	Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
	SM74611KTTR	DDPAK/TO-263	KTT	3	500	340.0	340.0	38.0

KTT (R-PSFM-G3)

PLASTIC FLANGE-MOUNT PACKAGE



NOTES:

- A. All linear dimensions are in millimeters.
- 3. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion. Mold flash or protrusion not to exceed 0.005 (0,13) per side.
- ⚠ Falls within JEDEC T0—263 variation AA, except minimum lead thickness and minimum exposed pad length.



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